

# S-5731 Series

# HIGH-WITHSTAND VOLTAGE HIGH-SPEED UNIPOLAR DETECTION TYPE HALL EFFECT SWITCH IC

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This IC, developed by CMOS technology, is a unipolar detection type Hall effect switch IC with high-withstand voltage, high-speed detection and high-accuracy magnetic characteristics.

The output voltage changes when this IC detects the intensity level of magnetic flux density. Using this IC with a magnet makes it possible to detect the open / close and rotation status in various devices.

This IC includes an output current limit circuit.

High-density mounting is possible by using the small SOT-23-3 package.

Due to its high-accuracy magnetic characteristics, this IC can make operation's dispersion in the system combined with magnet smaller.

ABLIC Inc. offers a "magnetic simulation service" that provides the ideal combination of magnets and our Hall effect ICs for customer systems. Our magnetic simulation service will reduce prototype production, development period and development costs. In addition, it will contribute to optimization of parts to realize high cost performance.

For more information regarding our magnetic simulation service, contact our sales office.

#### ■ Features

• Pole detection\*1: Detection of S pole, detection of N pole

Output logic\*1: Active "L", active "H"
 Output form\*1: Nch open-drain output,

Nch driver + built-in pull-up resistor

• Magnetic sensitivity\*<sup>1</sup>:  $B_{OP} = 3.0 \text{ mT typ.},$   $B_{OP} = 6.0 \text{ mT typ.}$ 

• Chopping frequency:  $f_C = 250 \text{ kHz typ.}$ • Output delay time:  $t_D = 16.0 \mu \text{s typ.}$ • Power supply voltage range:  $V_{DD} = 3.5 \text{ V to } 26.0 \text{ V}$ 

Built-in regulator

Built-in output current limit circuitOperation temperature range:

• Lead-free (Sn 100%), halogen-free

\*1. The option can be selected.

Ta =  $-40^{\circ}$ C to  $+85^{\circ}$ C

## Applications

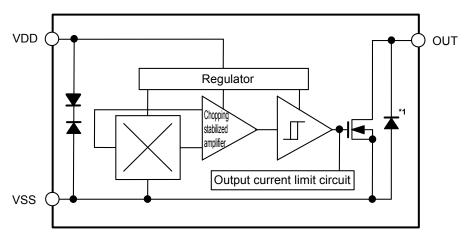
- Home appliance
- DC brushless motor
- Housing equipment
- Industrial equipment

### ■ Package

• SOT-23-3

# **■** Block Diagrams

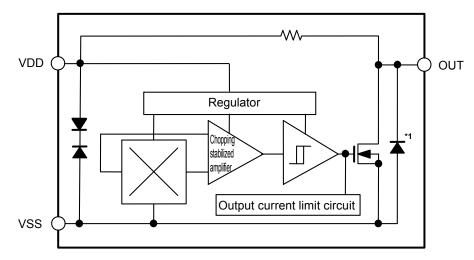
# 1. Nch open-drain output product



\*1. Parasitic diode

Figure 1

# 2. Nch driver + built-in pull-up resistor product



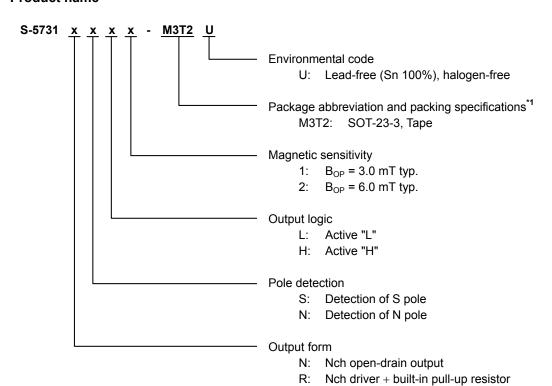
\*1. Parasitic diode

Figure 2

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### **■ Product Name Structure**

#### 1. Product name



<sup>\*1.</sup> Refer to the tape drawing.

## 2. Package

Table 1 Package Drawing Codes

Package Name	Dimension	Tape	Reel	
SOT-23-3	MP003-C-P-SD	MP003-C-C-SD	MP003-Z-R-SD	

#### 3. Product name list

Table 2

Product Name	Output Form	Pole Detection	Output Logic	Magnetic Sensitivity (B <sub>OP</sub> )
S-5731NSL1-M3T2U	Nch open-drain output	S pole	Active "L"	3.0 mT typ.
S-5731NSL2-M3T2U	Nch open-drain output	S pole	Active "L"	6.0 mT typ.
S-5731NNL2-M3T2U	Nch open-drain output	N pole	Active "L"	6.0 mT typ.
S-5731RSL1-M3T2U	Nch driver + built-in pull-up resistor	S pole	Active "L"	3.0 mT typ.

**Remark** Please contact our sales office for products other than the above.

# ■ Pin Configuration

## 1. SOT-23-3

Top view



Table 3

Pin No.	Symbol	Description
1	VSS	GND pin
2	VDD	Power supply pin
3	OUT	Output pin

Figure 3

# ■ Absolute Maximum Ratings

Table 4

(Ta =  $+25^{\circ}$ C unless otherwise specified)

	Item	Symbol	Absolute Maximum Rating	Unit
Power supply voltage		$V_{DD}$	$V_{SS}-0.3$ to $V_{SS}+28.0$	V
Output current		I <sub>OUT</sub>	20	mA
Nch open-drain output product			$V_{SS}-0.3$ to $V_{SS}+28.0$	V
Output voltage	Nch driver + built-in pull-up resistor product	V <sub>OUT</sub>	$V_{SS}-0.3$ to $V_{DD}+0.3$	V
Operation ambient temperature		T <sub>opr</sub>	−40 to +85	°C
Storage temperature		T <sub>stg</sub>	-40 to +125	°C

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

# ■ Thermal Resistance Value

Table 5

Item	Symbol	Condition	Min.	Тур.	Max.	Unit	
	$\theta_{JA}$		Board A	_	200	_	°C/W
		SOT-23-3	Board B	_	165	_	°C/W
Junction-to-ambient thermal resistance*1			Board C	_	ı	_	°C/W
			Board D	_	ı	_	°C/W
			Board E	-	_	_	°C/W

<sup>\*1.</sup> Test environment: compliance with JEDEC STANDARD JESD51-2A

Remark Refer to "■ Power Dissipation" and "Test Board" for details.

# **■** Electrical Characteristics

Table 6

(Ta = +25°C, V<sub>DD</sub> = 12.0 V, V<sub>SS</sub> = 0 V unless otherwise specified)

Item	Symbol	Condition		Тур.	Max.	Unit	Test Circuit
Power supply voltage	$V_{DD}$	-	3.5	12.0	26.0	V	_
Current consumption		Nch open-drain output product Average value	-	3.0	4.0	mA	1
Current consumption	I <sub>DD</sub>	Nch driver + built-in pull-up resistor product Average value, V <sub>OUT</sub> = "H"	ı	3.0	4.0	mA	1
Output valtage	\ \ V	Nch open-drain output product Output transistor Nch, $V_{OUT}$ = "L", $I_{OUT}$ = 10 mA	-	_	0.4	V	2
Output voltage	V <sub>OUT</sub>	Nch driver + built-in pull-up resistor product Output transistor Nch, V <sub>OUT</sub> = "L", I <sub>OUT</sub> = 10 mA		-	0.5	V	2
Output drop voltage	V <sub>D</sub>	Nch driver + built-in pull-up resistor product $V_{OUT}$ = "H", $V_D$ = $V_{DD} - V_{OUT}$	ı	_	20	mV	2
Leakage current	I <sub>LEAK</sub>	Nch open-drain output product Output transistor Nch, V <sub>OUT</sub> = "H" = 26.0 V	-	_	10	μА	3
Output limit current	I <sub>OM</sub>	V <sub>OUT</sub> = 12.0 V	22	_	70	mA	3
Output delay time	t <sub>D</sub>	ı	-	16.0	_	μS	_
Chopping frequency	$f_{C}$	ľ	-	250	_	kHz	_
Start up time	t <sub>PON</sub>	-	-	30	_	μS	4
Outrout vice time		Nch open-drain output product $C = 20 \text{ pF}, R = 820 \Omega$	-	_	2.0	μS	5
Output rise time t <sub>R</sub>		Nch driver + built-in pull-up resistor product C = 20 pF		_	6.0	μS	5
Output fall time	t <sub>F</sub>	C = 20 pF, R = 820 Ω	-	_	2.0	μS	5
Pull-up resistor	$R_L$	Nch driver + built-in pull-up resistor product	7	10	13	kΩ	_

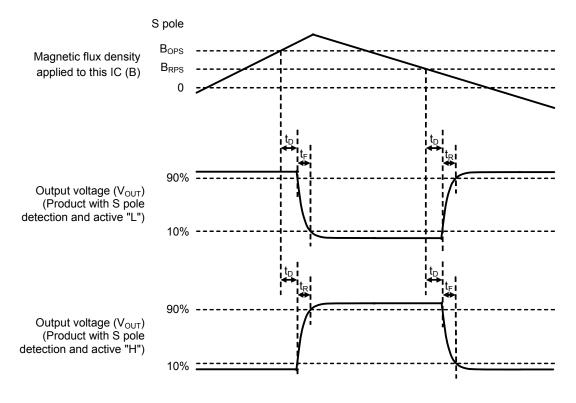


Figure 4 Operation Timing

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## ■ Magnetic Characteristics

#### 1. Product with S pole detection

1. 1 Product with  $B_{OP} = 3.0 \text{ mT typ.}$ 

#### Table 7

(Ta = +25°C,  $V_{DD}$  = 12.0 V,  $V_{SS}$  = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	B <sub>OPS</sub>	_	1.5	3.0	4.5	mT	4
Release point*2	S pole	B <sub>RPS</sub>	_	1.0	2.0	3.3	mT	4
Hysteresis width*3	S pole	B <sub>HYSS</sub>	$B_{HYSS} = B_{OPS} - B_{RPS}$	1	1.0	_	mT	4

#### 1. 2 Product with $B_{OP} = 6.0 \text{ mT typ.}$

#### Table 8

(Ta = +25°C,  $V_{DD}$  = 12.0 V,  $V_{SS}$  = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	S pole	B <sub>OPS</sub>	_	3.0	6.0	9.0	mT	4
Release point*2	S pole	B <sub>RPS</sub>	_	2.5	4.5	7.5	mT	4
Hysteresis width*3	S pole	B <sub>HYSS</sub>	$B_{HYSS} = B_{OPS} - B_{RPS}$	_	1.5	ì	mT	4

#### 2. Product with N pole detection

#### 2. 1 Product with $B_{OP} = 6.0 \text{ mT typ.}$

Table 9

(Ta = +25°C,  $V_{DD}$  = 12.0 V,  $V_{SS}$  = 0 V unless otherwise specified)

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Test Circuit
Operation point*1	N pole	B <sub>OPN</sub>	_	-9.0	-6.0	-3.0	mT	4
Release point*2	N pole	B <sub>RPN</sub>	_	-7.5	-4.5	-2.5	mT	4
Hysteresis width*3	N pole	B <sub>HYSN</sub>	$B_{HYSN} =  B_{OPN} - B_{RPN} $	ı	1.5	ı	mT	4

<sup>\*1.</sup> B<sub>OPN</sub>, B<sub>OPS</sub>: Operation points

 $B_{OPN}$  and  $B_{OPS}$  are the values of magnetic flux density when the output voltage ( $V_{OUT}$ ) changes after the magnetic flux density applied to this IC by the magnet (N pole or S pole) is increased (by moving the magnet closer).

Even when the magnetic flux density exceeds B<sub>OPN</sub> or B<sub>OPS</sub>, V<sub>OUT</sub> retains the status.

### **\*2.** B<sub>RPN</sub>, B<sub>RPS</sub>: Release points

 $B_{RPN}$  and  $B_{RPS}$  are the values of magnetic flux density when the output voltage ( $V_{OUT}$ ) changes after the magnetic flux density applied to this IC by the magnet (N pole or S pole) is decreased (the magnet is moved further away).

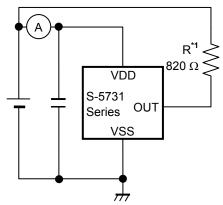
Even when the magnetic flux density falls below  $B_{RPN}$  or  $B_{RPS}$ ,  $V_{OUT}$  retains the status.

### \*3. B<sub>HYSN</sub>, B<sub>HYSS</sub>: Hysteresis widths

 $B_{HYSN}$  and  $B_{HYSS}$  are the difference between  $B_{OPN}$  and  $B_{RPN}$ , and  $B_{OPS}$  and  $B_{RPS}$ , respectively.

**Remark** The unit of magnetic density mT can be converted by using the formula 1 mT = 10 Gauss.

# **■** Test Circuits



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 5 Test Circuit 1

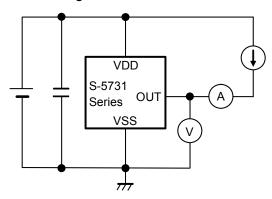


Figure 6 Test Circuit 2

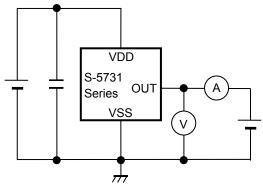
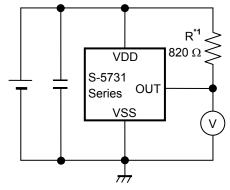
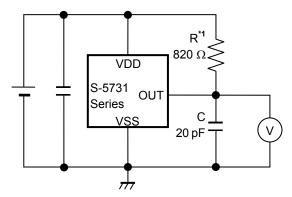


Figure 7 Test Circuit 3



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

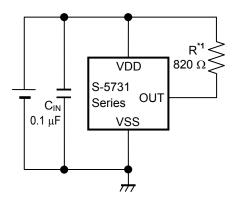
Figure 8 Test Circuit 4



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 9 Test Circuit 5

# **■** Standard Circuit



\*1. Resistor (R) is unnecessary for Nch driver + built-in pull-up resistor product.

Figure 10

Caution The above connection diagram and constant will not guarantee successful operation. Perform thorough evaluation using the actual application to set the constant.

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# ■ Operation

## 1. Direction of applied magnetic flux

This IC detects the magnetic flux density which is vertical to the marking surface.

Figure 11 shows the direction in which magnetic flux is being applied.

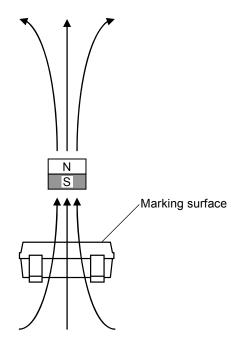


Figure 11

#### 2. Position of Hall sensor

Figure 12 shows the position of Hall sensor.

The center of this Hall sensor is located in the area indicated by a circle, which is in the center of a package as described below.

The following also shows the distance (typ. value) between the marking surface and the chip surface of a package.

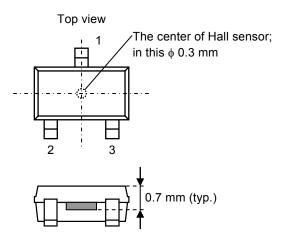


Figure 12

#### 3. Basic operation

This IC changes the output voltage  $(V_{OUT})$  according to the level of the magnetic flux density (N pole or S pole) applied by a magnet.

The following explains the operation when the output logic is active "L".

#### 3. 1 Product with S pole detection

When the magnetic flux density of the S pole perpendicular to the marking surface exceeds the operation point ( $B_{OPS}$ ) after the S pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "H" to "L". When the S pole of a magnet is moved further away from the marking surface of this IC and the magnetic flux density is lower than the release point ( $B_{RPS}$ ),  $V_{OUT}$  changes from "L" to "H".

Figure 13 shows the relationship between the magnetic flux density and V<sub>OUT</sub>.

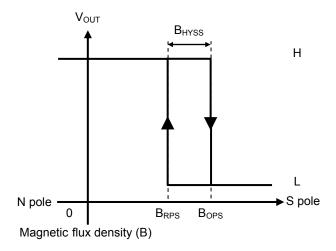


Figure 13

#### 3. 2 Product with N pole detection

When the magnetic flux density of the N pole perpendicular to the marking surface exceeds the operation point  $(B_{OPN})$  after the N pole of a magnet is moved closer to the marking surface of this IC,  $V_{OUT}$  changes from "H" to "L". When the N pole of a magnet is moved further away from the marking surface of this IC and the magnetic flux density of the N pole is lower than the release point  $(B_{RPN})$ ,  $V_{OUT}$  changes from "L" to "H".

Figure 14 shows the relationship between the magnetic flux density and  $V_{\text{OUT}}$ .

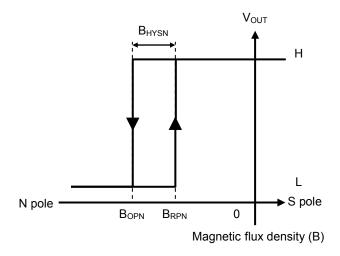


Figure 14

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## 4. Timing chart

**Figure 15** shows the operation timing at power-on.

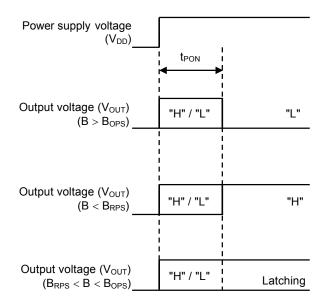
The initial output voltage at rising of power supply voltage (V<sub>DD</sub>) is either "H" or "L".

In case of B >  $B_{OPS}$  (operation point) or B <  $B_{RPS}$  (release point) at the time when the start up time ( $t_{PON}$ ) is passed after rising of  $V_{DD}$ , this IC outputs  $V_{OUT}$  according to the applied magnetic flux density.

In case of  $B_{\text{RPS}} < B < B_{\text{OPS}}$  at the time when  $t_{\text{PON}}$  is passed after rising of  $V_{\text{DD}}$ , this IC maintains the initial output voltage.

#### Product with S pole detection and active "L"

#### Product with S pole detection and active "H"



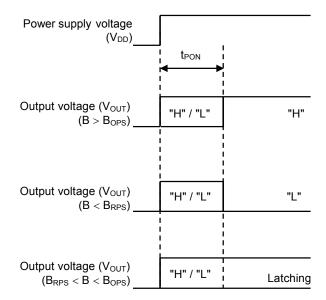


Figure 15

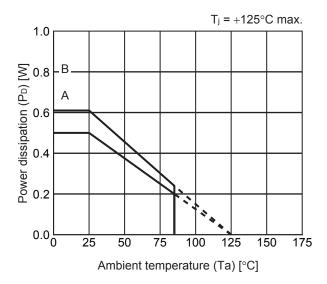
# HIGH-WITHSTAND VOLTAGE HIGH-SPEED UNIPOLAR DETECTION TYPE HALL EFFECT SWITCH IC S-5731 Series Rev.1.1\_01

#### ■ Precautions

- If the impedance of the power supply is high, the IC may malfunction due to a supply voltage drop caused by feedthrough current. Take care with the pattern wiring to ensure that the impedance of the power supply is low.
- Note that the IC may malfunction if the power supply voltage rapidly changes. When the IC is used under the environment where the power supply voltage rapidly changes, it is recommended to judge the output voltage of the IC by reading it multiple times.
- Note that the output voltage may rarely change if the magnetic flux density between the operation point and the release point is applied to this IC continuously for a long time.
- Do not apply an electrostatic discharge to this IC that exceeds the performance ratings of the built-in electrostatic protection circuit.
- Although this IC has a built-in output current limit circuit, it may suffer physical damage such as product deterioration under the environment where the absolute maximum ratings are exceeded.
- The application conditions for the power supply voltage, the pull-up voltage, and the pull-up resistor should not exceed the power dissipation.
- Large stress on this IC may affect on the magnetic characteristics. Avoid large stress which is caused by the handling during or after mounting the IC on a board.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.

# **■** Power Dissipation

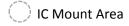
## SOT-23-3

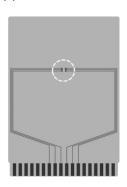


Board	Power Dissipation (P <sub>D</sub> )
Α	0.50 W
В	0.61 W
С	_
D	-
E	_

# **SOT-23-3/3S/5/6** Test Board

# (1) Board A





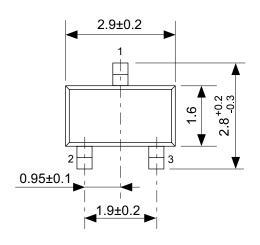
Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		2
	1	Land pattern and wiring for testing: t0.070
Copper foil layer [mm]	2	-
Copper foil layer [min]	3	-
	4	74.2 x 74.2 x t0.070
Thermal via		-

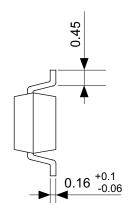
# (2) Board B

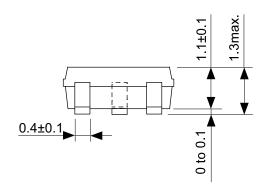


Item		Specification
Size [mm]		114.3 x 76.2 x t1.6
Material		FR-4
Number of copper foil layer		4
	1	Land pattern and wiring for testing: t0.070
Copper foil layer [mm]	2	74.2 x 74.2 x t0.035
Copper foli layer [min]	3	74.2 x 74.2 x t0.035
	4	74.2 x 74.2 x t0.070
Thermal via		-

No. SOT23x-A-Board-SD-2.0

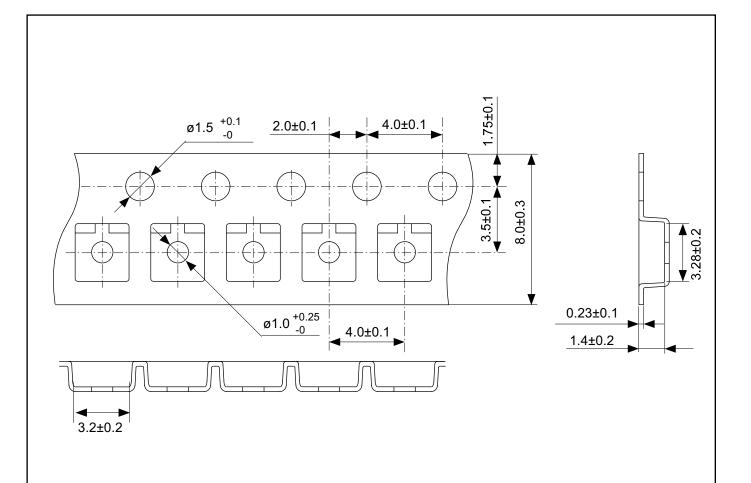


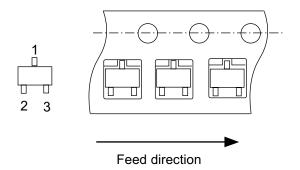




No. MP003-C-P-SD-1.1

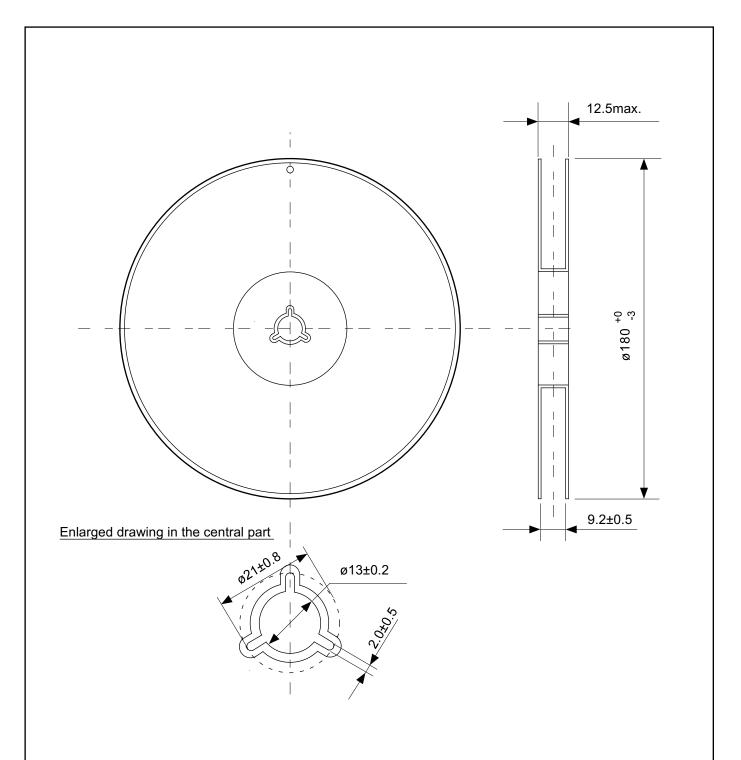
TITLE	SOT233-C-PKG Dimensions			
No.	MP003-C-P-SD-1.1			
ANGLE	<b>\$</b>			
UNIT	mm			
ABLIC Inc.				
ADLIC INC.				





# No. MP003-C-C-SD-2.0

TITLE	SOT233-C-Carrier Tape			
No.	MP003-C-C-SD-2.0			
ANGLE				
UNIT	mm			
ABLIC Inc.				
ADEIO IIIC.				



# No. MP003-Z-R-SD-1.0

TITLE	SOT233-C-Reel				
No.	MP003-Z-R-SD-1.0				
ANGLE		QTY.	3,000		
UNIT	mm				
ABLIC Inc.					

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SS460S-100SAMPLE 50065820-03 TLE4941PLUSCB AH374-P-A AH1806-P-A AH374-W-7 SS460P-T2 SI7201-B-20-IVR SS413F
TLE5046ICAKLRHALA1 TLE49421CHAMA2 TLE4941PLUSCXAMA1 AH1912-W-EVM AH1903-FA-EVM AH3774-W-EVM
AH49FNTR-EVM MMC5633NJL AH3360-FA-EVM AH8502-FDC-EVM AH3366Q-SA-EVM AH3774-P-EVM KTH1601SU-ST3
MG910 MG910M MG911 MG610 MW921 MW922 TLE4998S3XALA1 TLE5011FUMA1 TLE5027CE6747HAMA1
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